

**Notice of References Cited**Application/Control No.  
10/790,787Applicant(s)/Patent Under  
Reexamination  
SANSE ET AL.Examiner  
Edward ParkArt Unit  
2609

Page 1 of 2

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,975,969 A	12-1990	Tal, Peter	382/116
*	B	US-4,993,068 A	02-1991	Piosenka et al.	713/186
*	C	US-5,420,924 A	05-1995	Berson et al.	713/186
*	D	US-5,432,864 A	07-1995	Lu et al.	382/118
*	E	US-5,642,160 A	06-1997	Bennett, Michael Joseph	348/156
*	F	US-2002/0063151 A1	05-2002	OKUDA, OSAMU	235/380
*	G	US-2002/0116626 A1	08-2002	Wood, Roger D.	713/200
*	H	US-2002/0150277 A1	10-2002	Nishimoto et al.	382/100
*	I	US-2003/0086591 A1	05-2003	Simon, Rudy	382/115
*	J	US-2003/0123710 A1	07-2003	Nakazawa et al.	382/115
*	K	US-6,907,136 B1	06-2005	Shigemori, Yuriyo	382/118
*	L	US-7,039,221 B1	05-2006	Turney et al.	382/118
*	M	US-7,114,079 B1	09-2006	Cook et al.	713/186

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	(JP2002-152492, Sakuramoto, Japan, 05-2002, machine translation)
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>	Application/Control No. 10/790,787	Applicant(s)/Patent Under Reexamination SANSE ET AL.	
	Examiner Edward Park	Art Unit 2609	Page 2 of 2

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,163,094 A	11-1992	Prokoski et al.	382/118
*	B	US-4,993,068 A	02-1991	Piosenka et al.	713/186
*	C	US-5,719,951 A	02-1998	Shackleton et al.	382/118
*	D	US-5,787,186 A	07-1998	Schroeder, Carlos Cobian	382/115
*	E	US-6,128,398 A	10-2000	Kuperstein et al.	382/118
*	F	US-6,738,750 B2	05-2004	Stone et al.	705/26
*	G	US-2004/0243356 A1	12-2004	Duffy et al.	702/189
*	H	US-6,882,741 B2	04-2005	Dobashi et al.	382/118
*	I	US-2003/0086591 B2	05-2003	Simon, Rudy	382/115
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.